Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/824,229	INOUE, KEISHI	
,	Examiner	Art Unit	

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Theresa T. Doan

SEARCHED					
Class	Subclass	Date	Examiner		
257	751, 758	5/25/2007	TD		
257	775	5/25/2007	TD		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
257	758, 751	5/25/2007	TD		
	-				
US-PGPUB TEXT SEARCH, see interference search prinout		5/25/2007	TD		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST SEARCH (US PUB., US PAT., JPO, EPO, DERWENT) see Search History printout	5/25/2007	TD
257/e23.0\$\$	5/25/2007	TD